



BF1210

Dual N-channel dual gate MOSFET

Rev. 01 — 25 October 2006

Product data sheet

1. Product profile

1.1 General description

The BF1210 is a combination of two dual gate MOSFET amplifiers with shared source and gate2 leads.

The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor has a SOT363 micro-miniature plastic package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features

- Two low noise gain controlled amplifiers in a single package; both with a partly integrated bias
- Superior cross modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio

1.3 Applications

- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage
 - ◆ digital and analog television tuners
 - ◆ professional communication equipment

1.4 Quick reference data

Table 1. Quick reference data
Per MOSFET unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------|------------------------------|---|-----|-----|-----|------------------|
| V_{DS} | drain-source voltage | | - | - | 6 | V |
| I_D | drain current | DC | - | - | 30 | mA |
| P_{tot} | total power dissipation | $T_{sp} \leq 107\text{ }^\circ\text{C}$ | [1] | - | 180 | mW |
| $ y_{fs} $ | forward transfer admittance | amplifier A; $I_D = 19\text{ mA}$ | 26 | 31 | 41 | mS |
| | | amplifier B; $I_D = 13\text{ mA}$ | 28 | 33 | 43 | mS |
| $C_{iss(G1)}$ | input capacitance at gate1 | $f = 100\text{ MHz}$ | [2] | | | |
| | | amplifier A | - | 2.2 | 2.7 | pF |
| | | amplifier B | - | 1.9 | 2.4 | pF |
| C_{rss} | reverse transfer capacitance | $f = 100\text{ MHz}$ | [2] | 20 | - | fF |
| NF | noise figure | amplifier A; $f = 400\text{ MHz}$ | - | 0.9 | 1.5 | dB |
| | | amplifier B; $f = 800\text{ MHz}$ | - | 1.2 | 1.9 | dB |
| Xmod | cross modulation | input level for $k = 1\%$ at 40 dB AGC | | | | |
| | | amplifier A | 100 | 105 | - | dB μ V |
| | | amplifier B | 100 | 103 | - | dB μ V |
| T_j | junction temperature | | - | - | 150 | $^\circ\text{C}$ |

[1] T_{sp} is the temperature at the soldering point of the source lead.

[2] Calculated from S-parameters.

2. Pinning information

Table 2. Discrete pinning

| Pin | Description | Simplified outline | Symbol |
|-----|---------------|--------------------|--------|
| 1 | gate1 (AMP A) | | |
| 2 | gate2 | | |
| 3 | gate1 (AMP B) | | |
| 4 | drain (AMP B) | | |
| 5 | source | | |
| 6 | drain (AMP A) | | |

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3. Ordering information

Table 3. Ordering information

| Type number | Package | | Version |
|-------------|---------|--|---------|
| | Name | Description | |
| BF1210 | - | plastic surface-mounted package; 6 leads | SOT363 |

4. Marking

Table 4. Marking

| Type number | Marking | Description |
|-------------|---------|--|
| BF1210 | *AB | * = p : made in Hong Kong * = t : made in Malaysia * = w : made in China |

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-------------------|-------------------------|---|-----|----------|------------------|
| Per MOSFET | | | | | |
| V_{DS} | drain-source voltage | | - | 6 | V |
| I_D | drain current | DC | - | 30 | mA |
| I_{G1} | gate1 current | | - | ± 10 | mA |
| I_{G2} | gate2 current | | - | ± 10 | mA |
| P_{tot} | total power dissipation | $T_{sp} \leq 107\text{ }^\circ\text{C}$ [1] | - | 180 | mW |
| T_{stg} | storage temperature | | -65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | - | 150 | $^\circ\text{C}$ |

[1] T_{sp} is the temperature at the soldering point of the source lead.

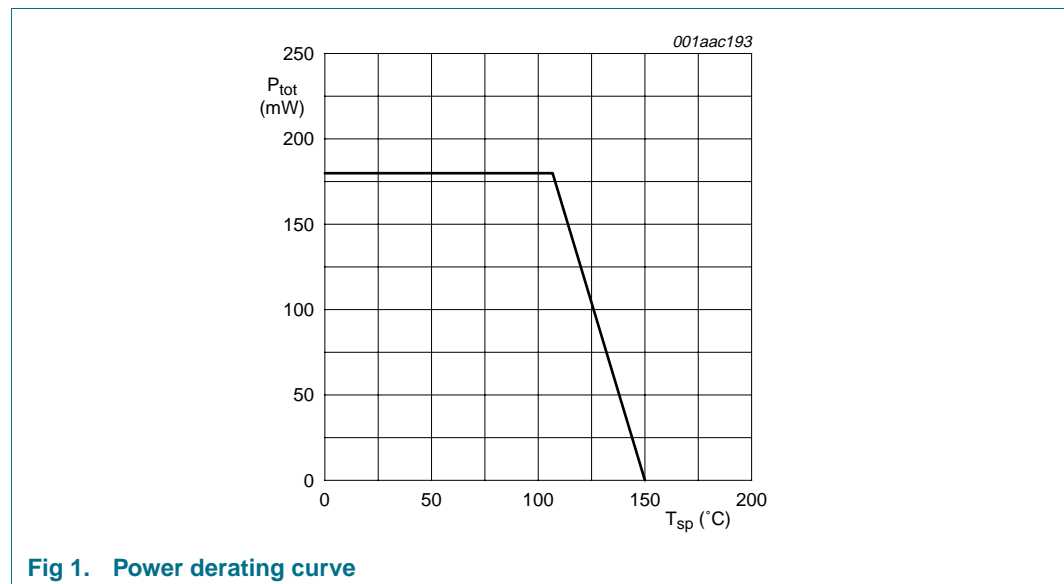


Fig 1. Power derating curve

6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Typ | Unit |
|----------------|--|------------|-----|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | | 240 | K/W |

7. Static characteristics

Table 7. Static characteristics

$T_j = 25\text{ }^\circ\text{C}$.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|--------------------------------|--|-----|-----|-----|------|
| Per MOSFET; unless otherwise specified | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $V_{G1-S} = V_{G2-S} = 0\text{ V}$; $I_D = 10\text{ }\mu\text{A}$ | | | | |
| | | amplifier A | 6 | - | - | V |
| | | amplifier B | 6 | - | - | V |
| $V_{(BR)G1-SS}$ | gate1-source breakdown voltage | $V_{G2-S} = V_{DS} = 0\text{ V}$; $I_{G1-S} = 10\text{ mA}$ | 6 | - | 10 | V |
| $V_{(BR)G2-SS}$ | gate2-source breakdown voltage | $V_{G1-S} = V_{DS} = 0\text{ V}$; $I_{G2-S} = 10\text{ mA}$ | 6 | - | 10 | V |
| $V_{F(S-G1)}$ | forward source-gate1 voltage | $V_{G2-S} = V_{DS} = 0\text{ V}$; $I_{S-G1} = 10\text{ mA}$ | 0.5 | - | 1.5 | V |
| $V_{F(S-G2)}$ | forward source-gate2 voltage | $V_{G1-S} = V_{DS} = 0\text{ V}$; $I_{S-G2} = 10\text{ mA}$ | 0.5 | - | 1.5 | V |
| $V_{G1-S(th)}$ | gate1-source threshold voltage | $V_{DS} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_D = 100\text{ }\mu\text{A}$ | 0.3 | - | 1.0 | V |
| $V_{G2-S(th)}$ | gate2-source threshold voltage | $V_{DS} = 5\text{ V}$; $V_{G1-S} = 5\text{ V}$; $I_D = 100\text{ }\mu\text{A}$ | 0.4 | - | 1.0 | V |
| I_{DS} | drain-source current | $V_{G2-S} = 4\text{ V}$ | [1] | | | |
| | | amplifier A; $V_{DS(A)} = 5\text{ V}$; $R_{G1(A)} = 59\text{ k}\Omega$ | 14 | - | 24 | mA |
| | | amplifier B; $V_{DS(B)} = 5\text{ V}$; $R_{G1(B)} = 150\text{ k}\Omega$ | 9 | - | 17 | mA |
| I_{G1-S} | gate1 cut-off current | $V_{G2-S} = 0\text{ V}$; $V_{DS(A)} = V_{DS(B)} = 0\text{ V}$ | | | | |
| | | amplifier A; $V_{G1-S(A)} = 5\text{ V}$ | - | - | 50 | nA |
| | | amplifier B; $V_{G1-S(B)} = 5\text{ V}$ | - | - | 50 | nA |
| I_{G2-S} | gate2 cut-off current | $V_{G2-S} = 4\text{ V}$; $V_{DS(A)} = V_{DS(B)} = 0\text{ V}$; $V_{G1-S(A)} = V_{G1-S(B)} = 0\text{ V}$ | - | - | 20 | nA |

[1] R_{G1} connects gate1 to $V_{GG} = 5\text{ V}$. See [Figure 32](#).

8. Dynamic characteristics

8.1 Dynamic characteristics for amplifier A

Table 8. Dynamic characteristics for amplifier A

Common source; $T_{amb} = 25\text{ }^\circ\text{C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(A)} = 5\text{ V}$; $I_{D(A)} = 19\text{ mA}$.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------|------------------------------|----------------------------------|-----|-----|-----|--------|
| $ y_{fs} $ | forward transfer admittance | $T_j = 25\text{ }^\circ\text{C}$ | 26 | 31 | 41 | mS |
| $C_{iss(G1)}$ | input capacitance at gate1 | $f = 100\text{ MHz}$ | [1] | - | 2.2 | 2.7 pF |
| $C_{iss(G2)}$ | input capacitance at gate2 | $f = 100\text{ MHz}$ | [1] | - | 3.0 | pF |
| C_{oss} | output capacitance | $f = 100\text{ MHz}$ | [1] | - | 0.9 | pF |
| C_{rss} | reverse transfer capacitance | $f = 100\text{ MHz}$ | [1] | - | 20 | fF |

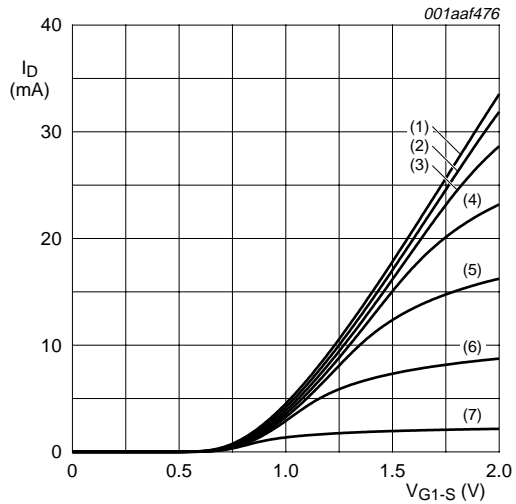
Table 8. Dynamic characteristics for amplifier A ...continued
 Common source; $T_{amb} = 25\text{ }^{\circ}\text{C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(A)} = 5\text{ V}$; $I_{D(A)} = 19\text{ mA}$.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|------------------|-----------------------|--|-----|-----|-----|------|
| G _{tr} | transducer power gain | B _S = B _{S(opt)} ; B _L = B _{L(opt)} | [1] | | | |
| | | f = 200 MHz; G _S = 2 mS; G _L = 0.5 mS | 31 | 35 | 39 | dB |
| | | f = 400 MHz; G _S = 2 mS; G _L = 1 mS | 27 | 31 | 35 | dB |
| | | f = 800 MHz; G _S = 3.3 mS; G _L = 1 mS | 22 | 26 | 30 | dB |
| NF | noise figure | f = 11 MHz; G _S = 20 mS; B _S = 0 S | - | 3 | - | dB |
| | | f = 400 MHz; Y _S = Y _{S(opt)} | - | 0.9 | 1.5 | dB |
| | | f = 800 MHz; Y _S = Y _{S(opt)} | - | 1.2 | 1.9 | dB |
| X _{mod} | cross modulation | input level for k = 1 %; f _w = 50 MHz; f _{unw} = 60 MHz | [2] | | | |
| | | at 0 dB AGC | 90 | - | - | dBμV |
| | | at 10 dB AGC | - | 90 | - | dBμV |
| | | at 20 dB AGC | - | 99 | - | dBμV |
| | | at 40 dB AGC | 100 | 105 | - | dBμV |

[1] Calculated from S-parameters.

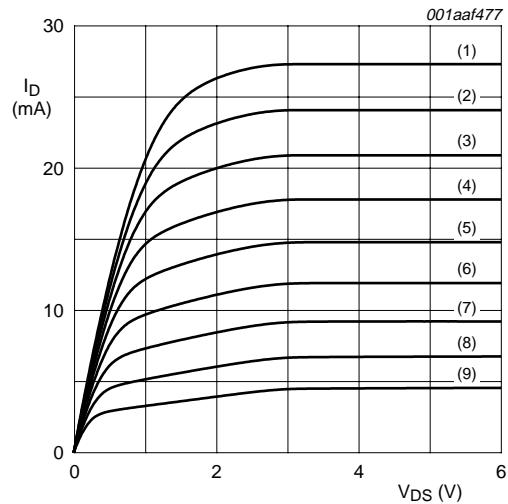
[2] Measured in [Figure 32](#) test circuit.

8.1.1 Graphs for amplifier A



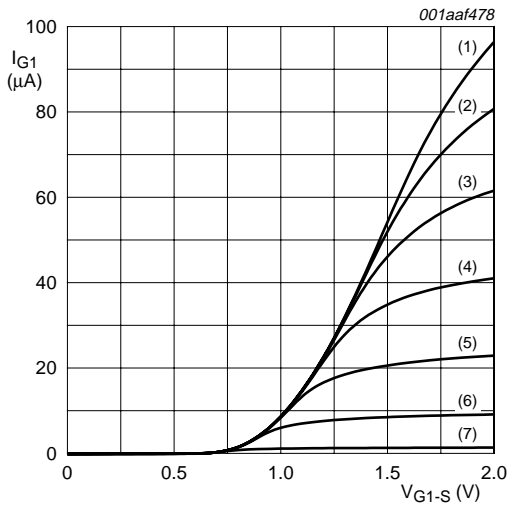
- (1) $V_{G2-S} = 4.0 \text{ V}$.
 - (2) $V_{G2-S} = 3.5 \text{ V}$.
 - (3) $V_{G2-S} = 3.0 \text{ V}$.
 - (4) $V_{G2-S} = 2.5 \text{ V}$.
 - (5) $V_{G2-S} = 2.0 \text{ V}$.
 - (6) $V_{G2-S} = 1.5 \text{ V}$.
 - (7) $V_{G2-S} = 1.0 \text{ V}$.
- $V_{DS(A)} = 5 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$.

Fig 2. Amplifier A: transfer characteristics; typical values



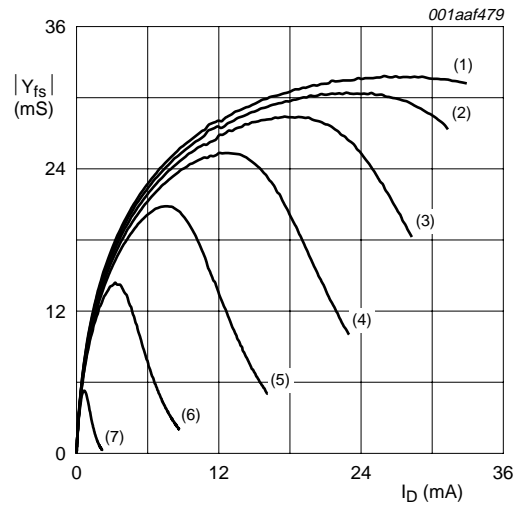
- (1) $V_{G1-S(A)} = 1.8 \text{ V}$.
 - (2) $V_{G1-S(A)} = 1.7 \text{ V}$.
 - (3) $V_{G1-S(A)} = 1.6 \text{ V}$.
 - (4) $V_{G1-S(A)} = 1.5 \text{ V}$.
 - (5) $V_{G1-S(A)} = 1.4 \text{ V}$.
 - (6) $V_{G1-S(A)} = 1.3 \text{ V}$.
 - (7) $V_{G1-S(A)} = 1.2 \text{ V}$.
 - (8) $V_{G1-S(A)} = 1.1 \text{ V}$.
 - (9) $V_{G1-S(A)} = 1.0 \text{ V}$.
- $V_{G2-S} = 4 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$.

Fig 3. Amplifier A: output characteristics; typical values



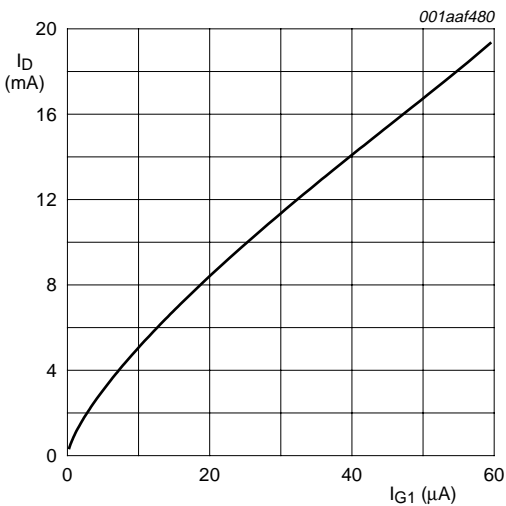
(1) $V_{G2-S} = 4.0\text{ V}$.
 (2) $V_{G2-S} = 3.5\text{ V}$.
 (3) $V_{G2-S} = 3.0\text{ V}$.
 (4) $V_{G2-S} = 2.5\text{ V}$.
 (5) $V_{G2-S} = 2.0\text{ V}$.
 (6) $V_{G2-S} = 1.5\text{ V}$.
 (7) $V_{G2-S} = 1.0\text{ V}$.
 $V_{DS(A)} = 5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$.

Fig 4. Amplifier A: gate1 current as a function of gate1 voltage; typical values



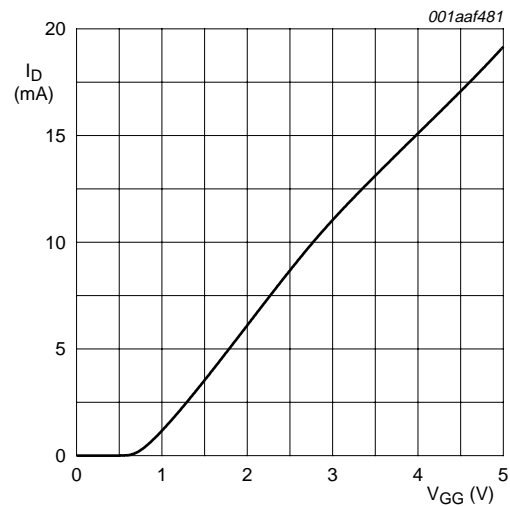
(1) $V_{G2-S} = 4.0\text{ V}$.
 (2) $V_{G2-S} = 3.5\text{ V}$.
 (3) $V_{G2-S} = 3.0\text{ V}$.
 (4) $V_{G2-S} = 2.5\text{ V}$.
 (5) $V_{G2-S} = 2.0\text{ V}$.
 (6) $V_{G2-S} = 1.5\text{ V}$.
 (7) $V_{G2-S} = 1.0\text{ V}$.
 $V_{DS(A)} = 5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$.

Fig 5. Amplifier A: forward transfer admittance as a function of drain current; typical values



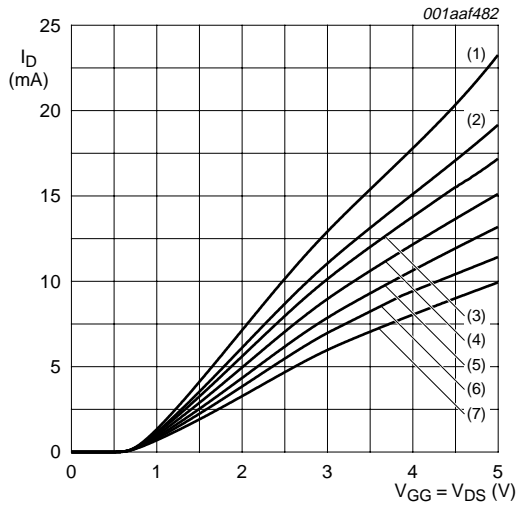
$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$.

Fig 6. Amplifier A: drain current as a function of gate1 current; typical values



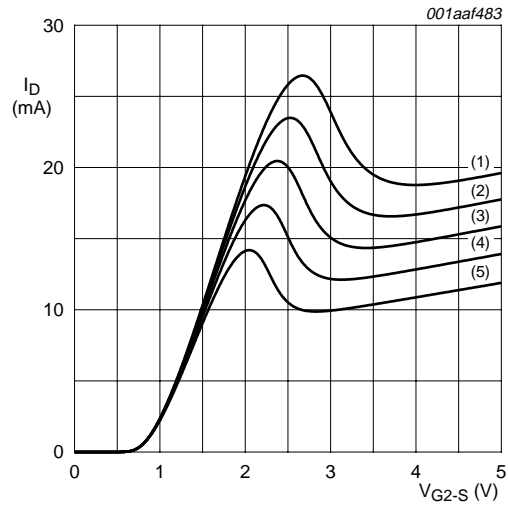
$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $R_{G1(A)} = 59\text{ k}\Omega$; $T_j = 25\text{ }^\circ\text{C}$.

Fig 7. Amplifier A: drain current as a function of gate1 supply voltage (V_{GG}); typical values



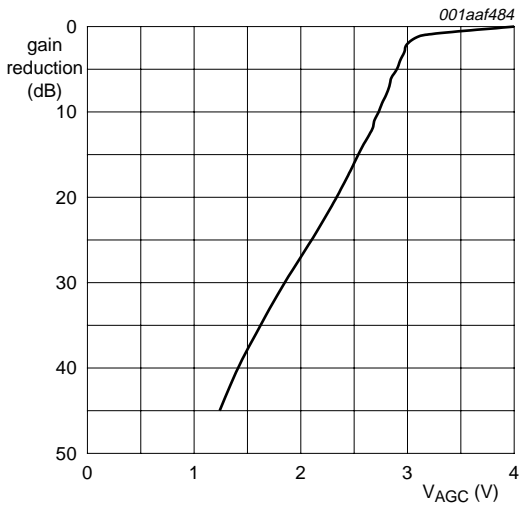
- (1) $R_{G1(A)} = 47 \text{ k}\Omega$.
 - (2) $R_{G1(A)} = 59 \text{ k}\Omega$.
 - (3) $R_{G1(A)} = 68 \text{ k}\Omega$.
 - (4) $R_{G1(A)} = 82 \text{ k}\Omega$.
 - (5) $R_{G1(A)} = 100 \text{ k}\Omega$.
 - (6) $R_{G1(A)} = 120 \text{ k}\Omega$.
 - (7) $R_{G1(A)} = 150 \text{ k}\Omega$.
- $V_{G2-S} = 4 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$.

Fig 8. Amplifier A: drain current as a function of V_{DS} and V_{GG} ; typical values



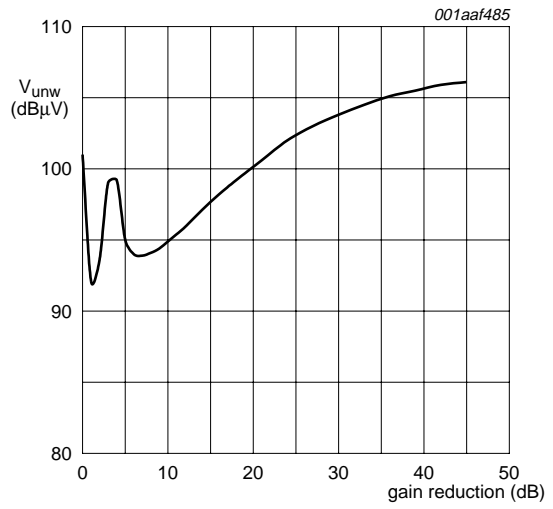
- (1) $V_{GG} = 5.0 \text{ V}$.
 - (2) $V_{GG} = 4.5 \text{ V}$.
 - (3) $V_{GG} = 4.0 \text{ V}$.
 - (4) $V_{GG} = 3.5 \text{ V}$.
 - (5) $V_{GG} = 3.0 \text{ V}$.
- $T_j = 25 \text{ }^\circ\text{C}; R_{G1(A)} = 59 \text{ k}\Omega$ (connected to V_{GG}).

Fig 9. Amplifier A: drain current as a function of gate2 voltage; typical values



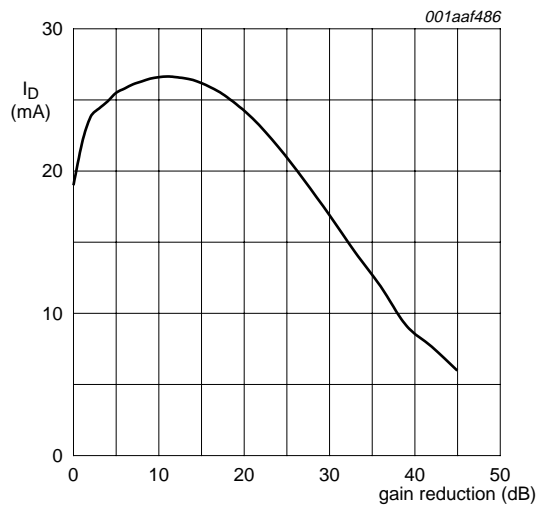
$V_{DS(A)} = 5\text{ V}$; $V_{GG} = 5\text{ V}$; $I_{D(nom)(A)} = 19\text{ mA}$;
 $R_{G1(A)} = 59\text{ k}\Omega$; $f = 50\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$;
 see [Figure 32](#).

Fig 10. Amplifier A: typical gain reduction as a function of the AGC voltage; typical values



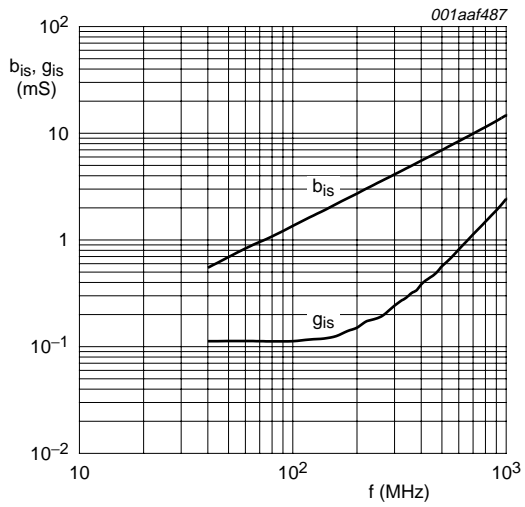
$V_{DS(A)} = 5\text{ V}$; $V_{GG} = 5\text{ V}$; $V_{G2-S(nom)} = 4\text{ V}$;
 $R_{G1(A)} = 59\text{ k}\Omega$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$;
 $I_{D(nom)(A)} = 19\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see [Figure 32](#).

Fig 11. Amplifier A: unwanted voltage for 1% cross modulation as a function of gain reduction; typical values



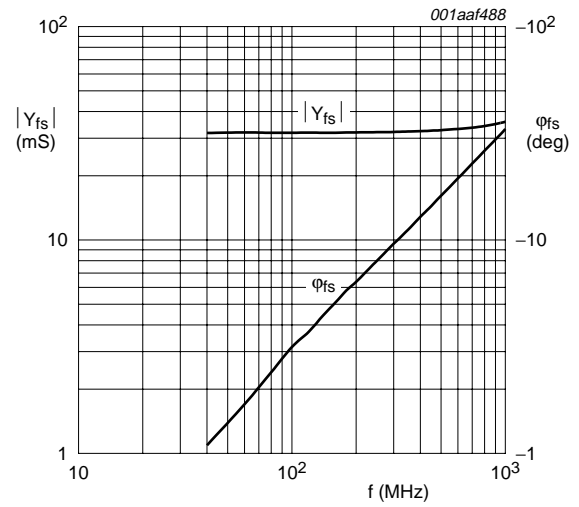
$V_{DS(A)} = 5\text{ V}$; $V_{GG} = 5\text{ V}$; $V_{G2-S(nom)} = 4\text{ V}$; $R_{G1(A)} = 59\text{ k}\Omega$; $f = 50\text{ MHz}$; $I_{D(nom)(A)} = 19\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see [Figure 32](#).

Fig 12. Amplifier A: typical drain current as a function of gain reduction; typical values



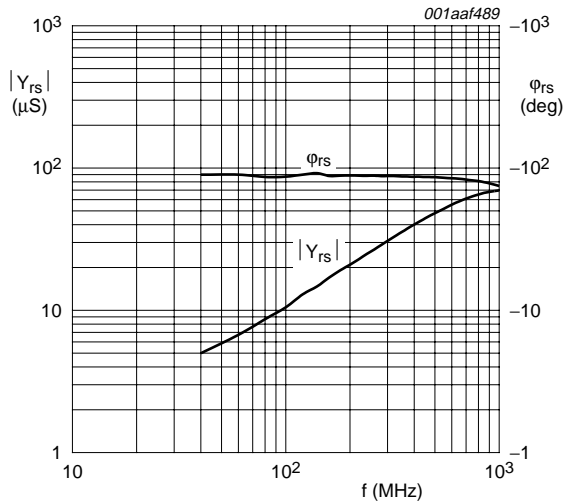
$V_{DS(A)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(B)} = 0\text{ V};$
 $I_{D(A)} = 19\text{ mA}.$

Fig 13. Amplifier A: input admittance as a function of frequency; typical values



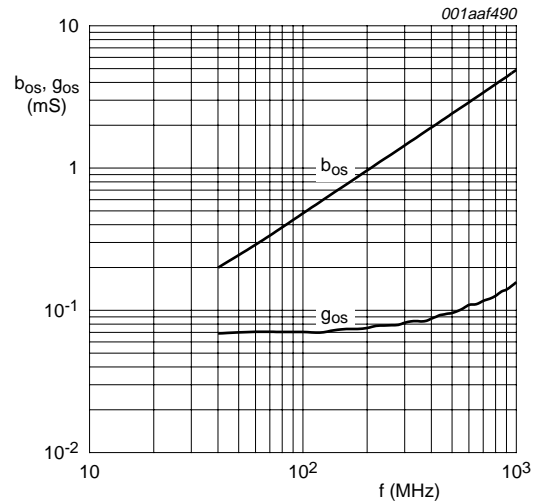
$V_{DS(A)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(B)} = 0\text{ V};$
 $I_{D(A)} = 19\text{ mA}.$

Fig 14. Amplifier A: forward transfer admittance and phase as a function of frequency; typical values



$V_{DS(A)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(B)} = 0\text{ V};$
 $I_{D(A)} = 19\text{ mA}.$

Fig 15. Amplifier A: reverse transfer admittance and phase as a function of frequency; typical values



$V_{DS(A)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(B)} = 0\text{ V};$
 $I_{D(A)} = 19\text{ mA}.$

Fig 16. Amplifier A: output admittance as a function of frequency; typical values

8.1.2 Scattering parameters for amplifier A

Table 9. Scattering parameters for amplifier A

$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(A)} = 19\text{ mA}$; $V_{DS(B)} = 0\text{ V}$; $V_{G1-S(B)} = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; typical values.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|---------|-------------------|-------------|-------------------|-------------|-------------------|-------------|-------------------|-------------|
| | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) |
| 40 | 0.9861 | -3.2 | 3.14 | 176.75 | 0.00054 | 87.97 | 0.9934 | -1.19 |
| 100 | 0.9883 | -7.84 | 3.14 | 171.53 | 0.00104 | 87.69 | 0.9925 | -2.85 |
| 200 | 0.9844 | -15.7 | 3.12 | 163.1 | 0.00205 | 80.77 | 0.9918 | -5.69 |
| 300 | 0.9761 | -23.52 | 3.08 | 154.65 | 0.00295 | 76.33 | 0.9904 | -8.51 |
| 400 | 0.9635 | -31.26 | 3.03 | 146.33 | 0.00375 | 72.34 | 0.9888 | -11.33 |
| 500 | 0.9486 | -38.78 | 2.97 | 138.15 | 0.00437 | 67.97 | 0.9870 | -14.13 |
| 600 | 0.9305 | -46.2 | 2.90 | 130.12 | 0.00483 | 64.86 | 0.9847 | -16.87 |
| 700 | 0.9105 | -53.33 | 2.81 | 122.26 | 0.0051 | 62.13 | 0.9832 | -19.61 |
| 800 | 0.8911 | -60.2 | 2.73 | 114.65 | 0.0052 | 59.88 | 0.9817 | -22.35 |
| 900 | 0.8723 | -67.03 | 2.65 | 107.2 | 0.00515 | 58.8 | 0.9796 | -25.03 |
| 1000 | 0.8521 | -73.74 | 2.56 | 99.78 | 0.00498 | 58.03 | 0.9785 | -27.08 |

8.2 Noise data for amplifier A

Table 10. Noise data for amplifier A

$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(A)} = 19\text{ mA}$, $T_{amb} = 25\text{ °C}$; typical values.

| f (MHz) | NF _{min} (dB) | Γ _{opt} | | r _n (ratio) |
|---------|------------------------|------------------|-------|------------------------|
| | | (ratio) | (deg) | |
| 400 | 0.9 | 0.749 | 23.7 | 0.667 |
| 800 | 1.2 | 0.688 | 48.65 | 0.583 |

8.3 Dynamic characteristics for amplifier B

Table 11. Dynamic characteristics for amplifier B

Common source; $T_{amb} = 25\text{ °C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(B)} = 5\text{ V}$; $I_{D(B)} = 13\text{ mA}$.

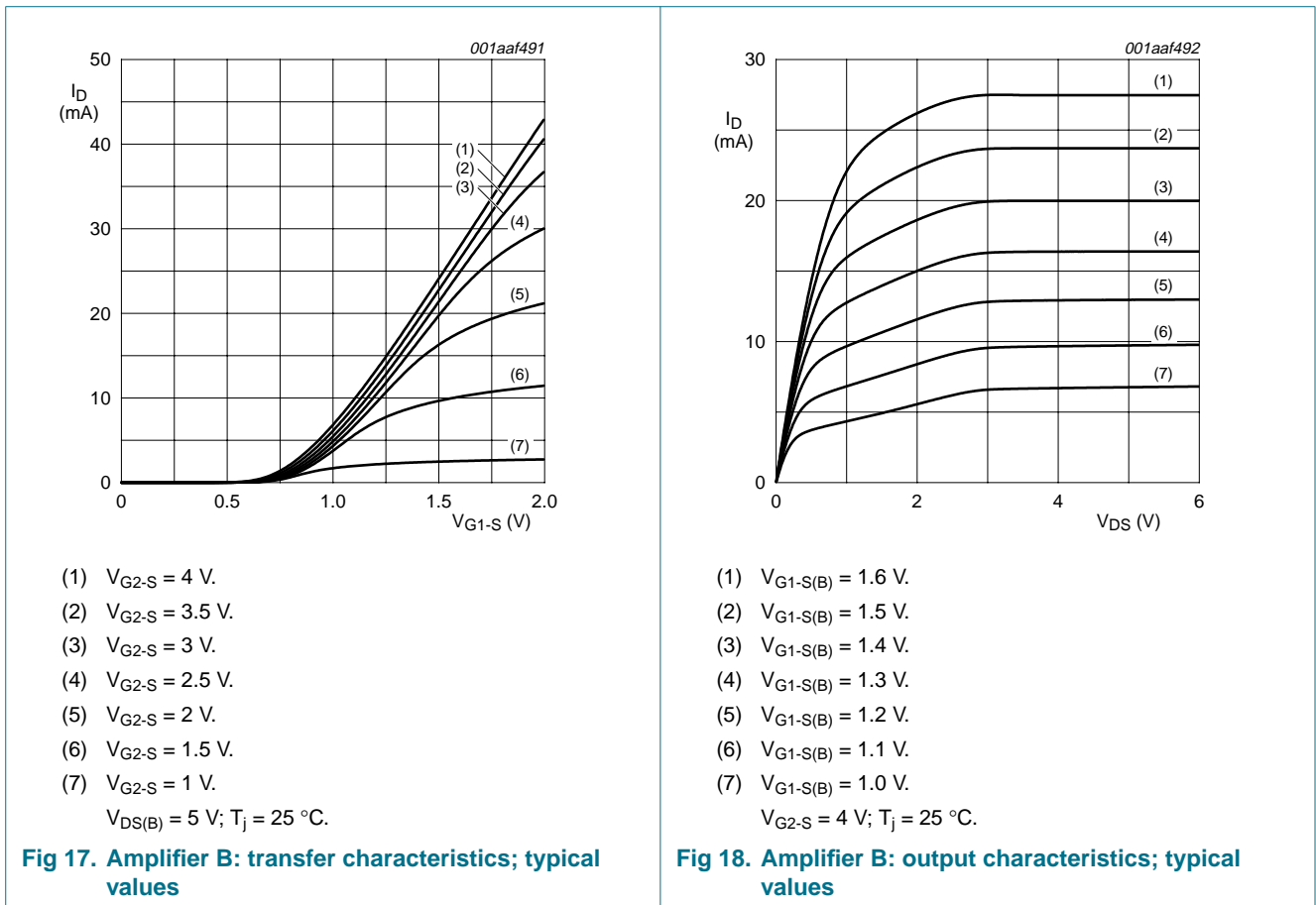
| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------------|------------------------------|---|-----|-----|------|--------|
| y _{fsl} | forward transfer admittance | T _j = 25 °C | 28 | 33 | 43 | mS |
| C _{iss(G1)} | input capacitance at gate1 | f = 100 MHz | [1] | - | 1.9 | 2.4 pF |
| C _{iss(G2)} | input capacitance at gate2 | f = 100 MHz | [1] | - | 3.4 | - pF |
| C _{oss} | output capacitance | f = 100 MHz | [1] | - | 0.85 | - pF |
| C _{rss} | reverse transfer capacitance | f = 100 MHz | [1] | - | 20 | - fF |
| G _{tr} | transducer power gain | B _S = B _{S(opt)} ; B _L = B _{L(opt)} | [1] | | | |
| | | f = 200 MHz; G _S = 2 mS; G _L = 0.5 mS | 32 | 36 | 40 | dB |
| | | f = 400 MHz; G _S = 2 mS; G _L = 1 mS | 29 | 33 | 37 | dB |
| | | f = 800 MHz; G _S = 3.3 mS; G _L = 1 mS | 27 | 31 | 35 | dB |
| NF | noise figure | f = 11 MHz; G _S = 20 mS; B _S = 0 S | - | 4 | - | dB |
| | | f = 400 MHz; Y _S = Y _{S(opt)} | - | 0.9 | 1.5 | dB |
| | | f = 800 MHz; Y _S = Y _{S(opt)} | - | 1.2 | 1.9 | dB |

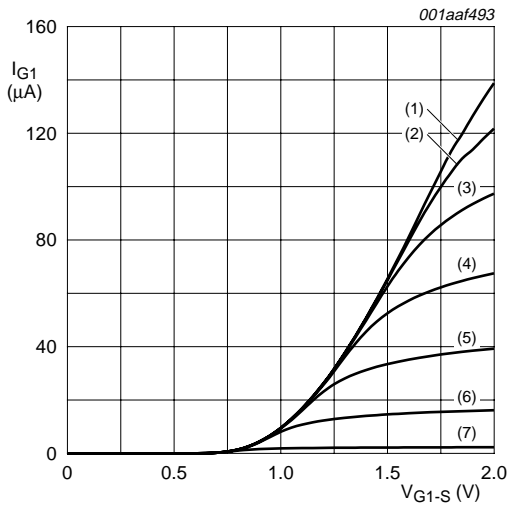
Table 11. Dynamic characteristics for amplifier B ...continued
 Common source; $T_{amb} = 25\text{ }^{\circ}\text{C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(B)} = 5\text{ V}$; $I_{D(B)} = 13\text{ mA}$.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--------|------------------|--|-----|-----|-----|------------|
| Xmod | cross modulation | input level for $k = 1\%$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$ | [2] | | | |
| | | at 0 dB AGC | 90 | - | - | dB μ V |
| | | at 10 dB AGC | - | 88 | - | dB μ V |
| | | at 20 dB AGC | - | 94 | - | dB μ V |
| | | at 40 dB AGC | 100 | 103 | - | dB μ V |

- [1] Calculated from S-parameters.
- [2] Measured in [Figure 32](#) test circuit.

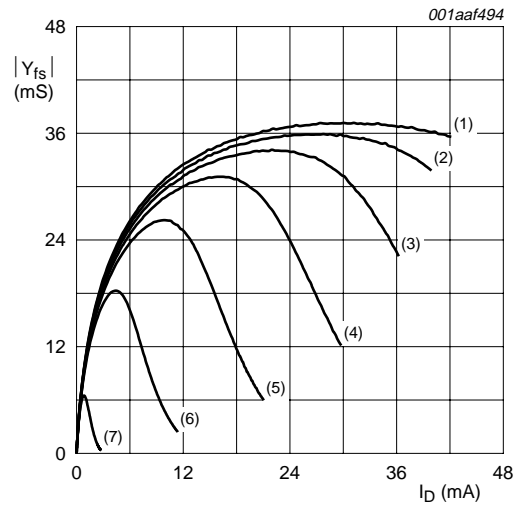
8.3.1 Graphs for amplifier B





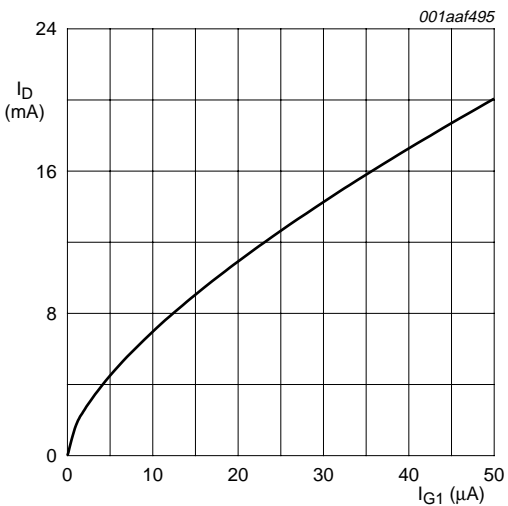
- (1) $V_{G2-S} = 4 \text{ V}$.
 - (2) $V_{G2-S} = 3.5 \text{ V}$.
 - (3) $V_{G2-S} = 3 \text{ V}$.
 - (4) $V_{G2-S} = 2.5 \text{ V}$.
 - (5) $V_{G2-S} = 2 \text{ V}$.
 - (6) $V_{G2-S} = 1.5 \text{ V}$.
 - (7) $V_{G2-S} = 1 \text{ V}$.
- $V_{DS(B)} = 5 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$.

Fig 19. Amplifier B: gate1 current as a function of gate1 voltage; typical values



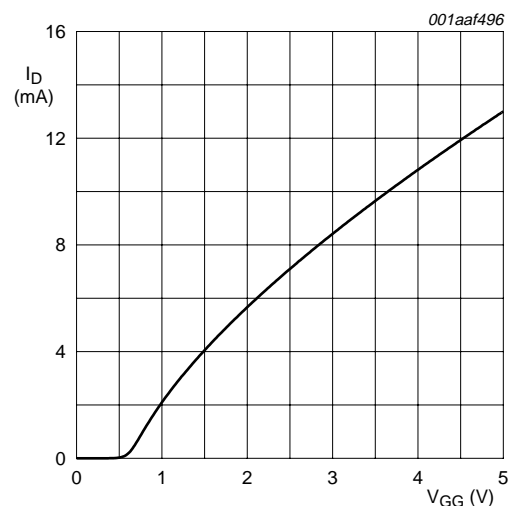
- (1) $V_{G2-S} = 4 \text{ V}$.
 - (2) $V_{G2-S} = 3.5 \text{ V}$.
 - (3) $V_{G2-S} = 3 \text{ V}$.
 - (4) $V_{G2-S} = 2.5 \text{ V}$.
 - (5) $V_{G2-S} = 2 \text{ V}$.
 - (6) $V_{G2-S} = 1.5 \text{ V}$.
 - (7) $V_{G2-S} = 1 \text{ V}$.
- $V_{DS(B)} = 5 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$.

Fig 20. Amplifier B: forward transfer admittance as a function of drain current; typical values



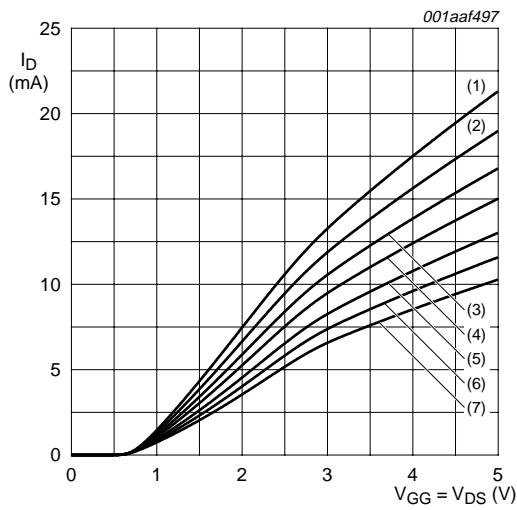
$V_{DS(B)} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$.

Fig 21. Amplifier B: drain current as a function of gate1 current; typical values



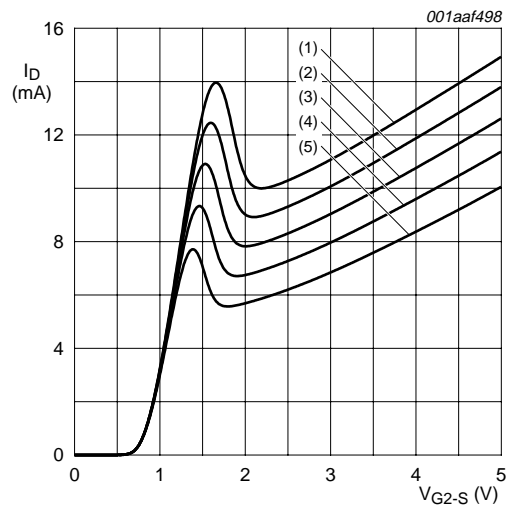
$V_{DS(B)} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; R_{G1(B)} = 150 \text{ k}\Omega;$
 $T_j = 25 \text{ }^\circ\text{C}$.

Fig 22. Amplifier B: drain voltage as a function of gate1 supply voltage (V_{GG}); typical values



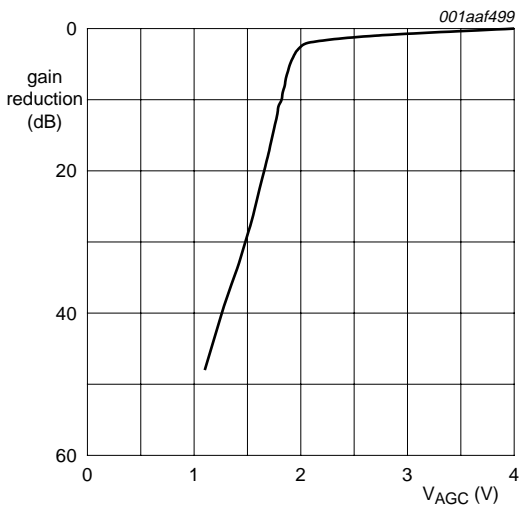
- (1) $R_{G1(B)} = 68 \text{ k}\Omega$.
 - (2) $R_{G1(B)} = 82 \text{ k}\Omega$.
 - (3) $R_{G1(B)} = 100 \text{ k}\Omega$.
 - (4) $R_{G1(B)} = 120 \text{ k}\Omega$.
 - (5) $R_{G1(B)} = 150 \text{ k}\Omega$.
 - (6) $R_{G1(B)} = 180 \text{ k}\Omega$.
 - (7) $R_{G1(B)} = 220 \text{ k}\Omega$.
- $V_{G2-S} = 5 \text{ V}$; $R_{G1(B)}$ connected to V_{GG} ; $T_j = 25 \text{ }^\circ\text{C}$.

Fig 23. Amplifier B: drain current as a function of V_{DS} and V_{GG} ; typical values



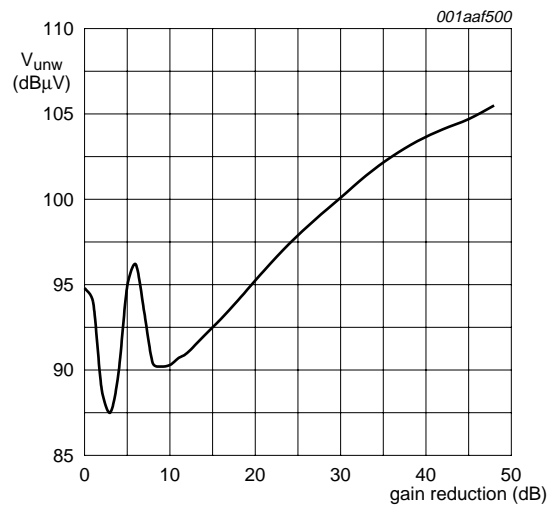
- (1) $V_{GG} = 5.0 \text{ V}$.
 - (2) $V_{GG} = 4.5 \text{ V}$.
 - (3) $V_{GG} = 4.0 \text{ V}$.
 - (4) $V_{GG} = 3.5 \text{ V}$.
 - (5) $V_{GG} = 3.0 \text{ V}$.
- $R_{G1(B)} = 150 \text{ k}\Omega$; $T_j = 25 \text{ }^\circ\text{C}$.

Fig 24. Amplifier B: drain current as a function of gate2 voltage; typical values



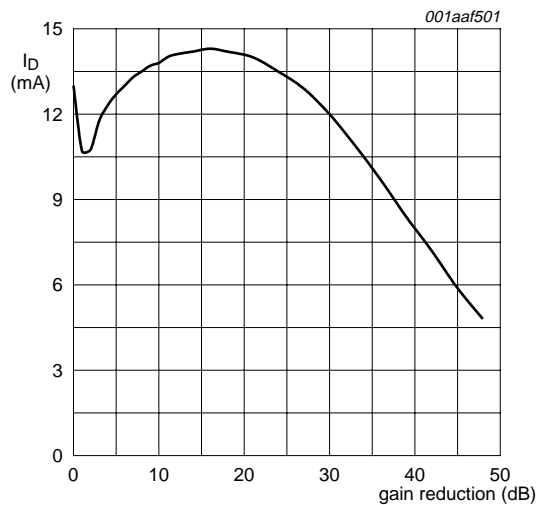
$V_{DS(B)} = 5\text{ V}$; $V_{G2-S(nom)} = 4\text{ V}$; $R_{G1(B)} = 150\text{ k}\Omega$;
 $I_{D(nom)(B)} = 13\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see [Figure 32](#).

Fig 25. Amplifier B: typical gain reduction as a function of the AGC voltage; typical values



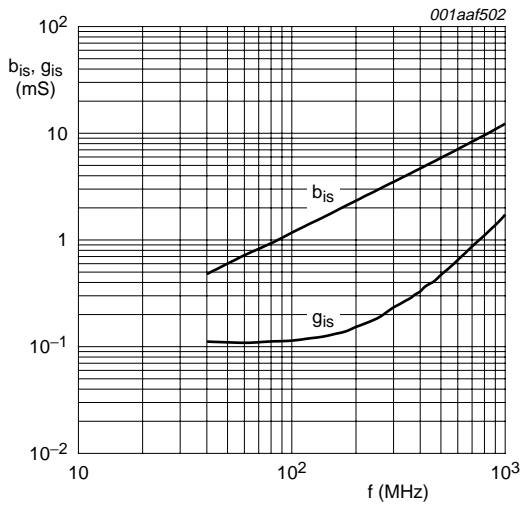
$V_{DS(B)} = 5\text{ V}$; $V_{G2-S(nom)} = 4\text{ V}$; $R_{G1(B)} = 150\text{ k}\Omega$;
 $I_{D(nom)(B)} = 13\text{ mA}$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$;
 $T_{amb} = 25\text{ }^\circ\text{C}$; see [Figure 32](#).

Fig 26. Amplifier B: unwanted voltage for 1 % cross modulation as a function of gain reduction; typical values



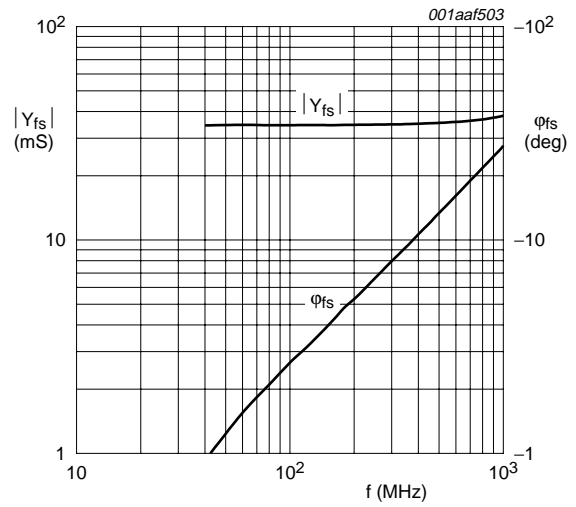
$V_{DS(B)} = V_{GG} = 5\text{ V}$; $V_{G2-S(nom)} = 4\text{ V}$; $R_{G1(B)} = 150\text{ k}\Omega$; $I_{D(nom)(B)} = 13\text{ mA}$; $f = 50\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see [Figure 32](#).

Fig 27. Amplifier B: typical drain current as a function of gain reduction; typical values



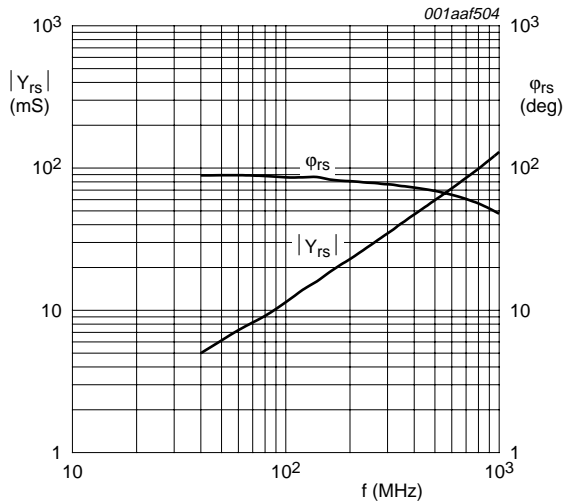
$V_{DS(B)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(A)} = 0\text{ V};$
 $I_{D(B)} = 13\text{ mA}.$

Fig 28. Amplifier B: input admittance as a function of frequency; typical values



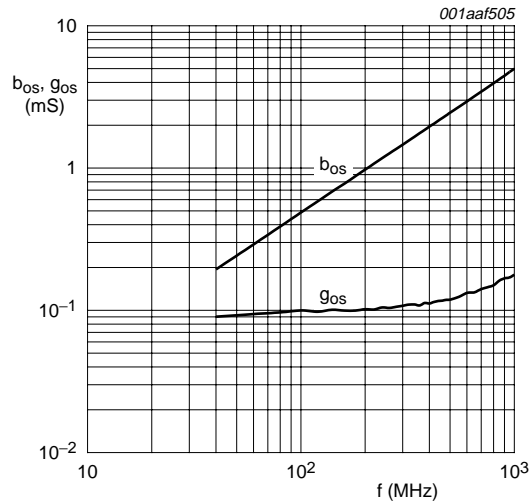
$V_{DS(B)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(A)} = 0\text{ V};$
 $I_{D(B)} = 13\text{ mA}.$

Fig 29. Amplifier B: forward transfer admittance and phase as a function of frequency; typical values



$V_{DS(B)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(A)} = 0\text{ V};$
 $I_{D(B)} = 13\text{ mA}.$

Fig 30. Amplifier B: reverse transfer admittance and phase as a function of frequency; typical values



$V_{DS(B)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(A)} = 0\text{ V};$
 $I_{D(B)} = 13\text{ mA}.$

Fig 31. Amplifier B: output admittance as a function of frequency; typical values

8.3.2 Scattering parameters for amplifier B

Table 12. Scattering parameters for amplifier B

$V_{DS(B)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(B)} = 13\text{ mA}$; $V_{DS(A)} = 0\text{ V}$; $V_{G1-S(A)} = 0\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; typical values.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|---------|-------------------|-------------|-------------------|-------------|-------------------|-------------|-------------------|-------------|
| | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) | Magnitude (ratio) | Angle (deg) |
| 40 | 0.9874 | -2.79 | 3.41 | 177.08 | 0.00054 | 89.27 | 0.992 | -1.26 |
| 100 | 0.9883 | -6.8 | 3.41 | 172.57 | 0.00113 | 90.81 | 0.9900 | -2.91 |
| 200 | 0.9844 | -13.52 | 3.39 | 165.23 | 0.00224 | 89.67 | 0.9897 | -5.81 |
| 300 | 0.9777 | -20.2 | 3.36 | 157.88 | 0.00336 | 89.02 | 0.9889 | -8.7 |
| 400 | 0.9684 | -26.83 | 3.32 | 150.6 | 0.00447 | 88.43 | 0.9881 | -11.61 |
| 500 | 0.9578 | -33.32 | 3.27 | 143.38 | 0.0055 | 87.64 | 0.9870 | -14.52 |
| 600 | 0.9442 | -39.8 | 3.21 | 136.22 | 0.00649 | 87.53 | 0.9851 | -17.39 |
| 700 | 0.9291 | -46.08 | 3.16 | 129.15 | 0.00741 | 87.51 | 0.9838 | -20.3 |
| 800 | 0.9147 | -52.18 | 3.08 | 122.25 | 0.00828 | 87.7 | 0.9825 | -23.2 |
| 900 | 0.9002 | -58.35 | 3.08 | 115.4 | 0.00914 | 88.14 | 0.9803 | -26.06 |
| 1000 | 0.8836 | -64.49 | 2.93 | 108.49 | 0.00997 | 88.26 | 0.9789 | -29.03 |

8.4 Noise data for amplifier B

Table 13. Noise data for amplifier B

$V_{DS(B)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(B)} = 13\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; typical values.

| f (MHz) | NF _{min} (dB) | Γ _{opt} | | r _n (ratio) |
|---------|------------------------|------------------|-------|------------------------|
| | | (ratio) | (deg) | |
| 400 | 0.9 | 0.743 | 20.27 | 0.65 |
| 800 | 1.2 | 0.687 | 42.08 | 0.581 |

9. Test information

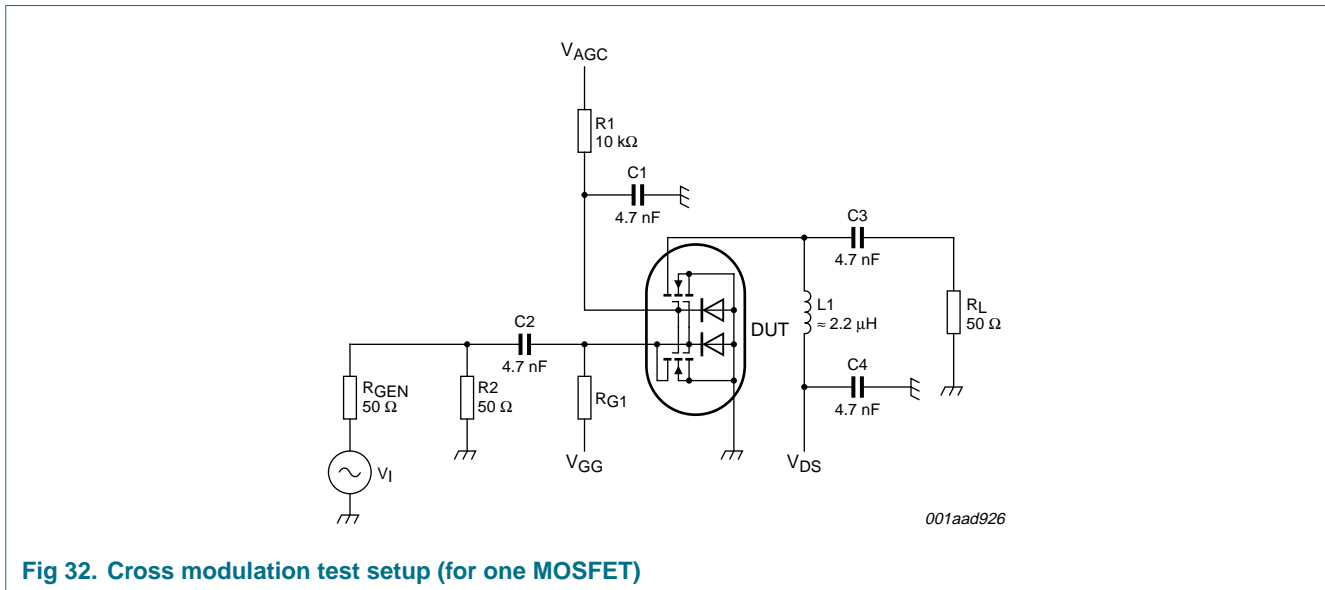


Fig 32. Cross modulation test setup (for one MOSFET)

10. Package outline

Plastic surface-mounted package; 6 leads

SOT363

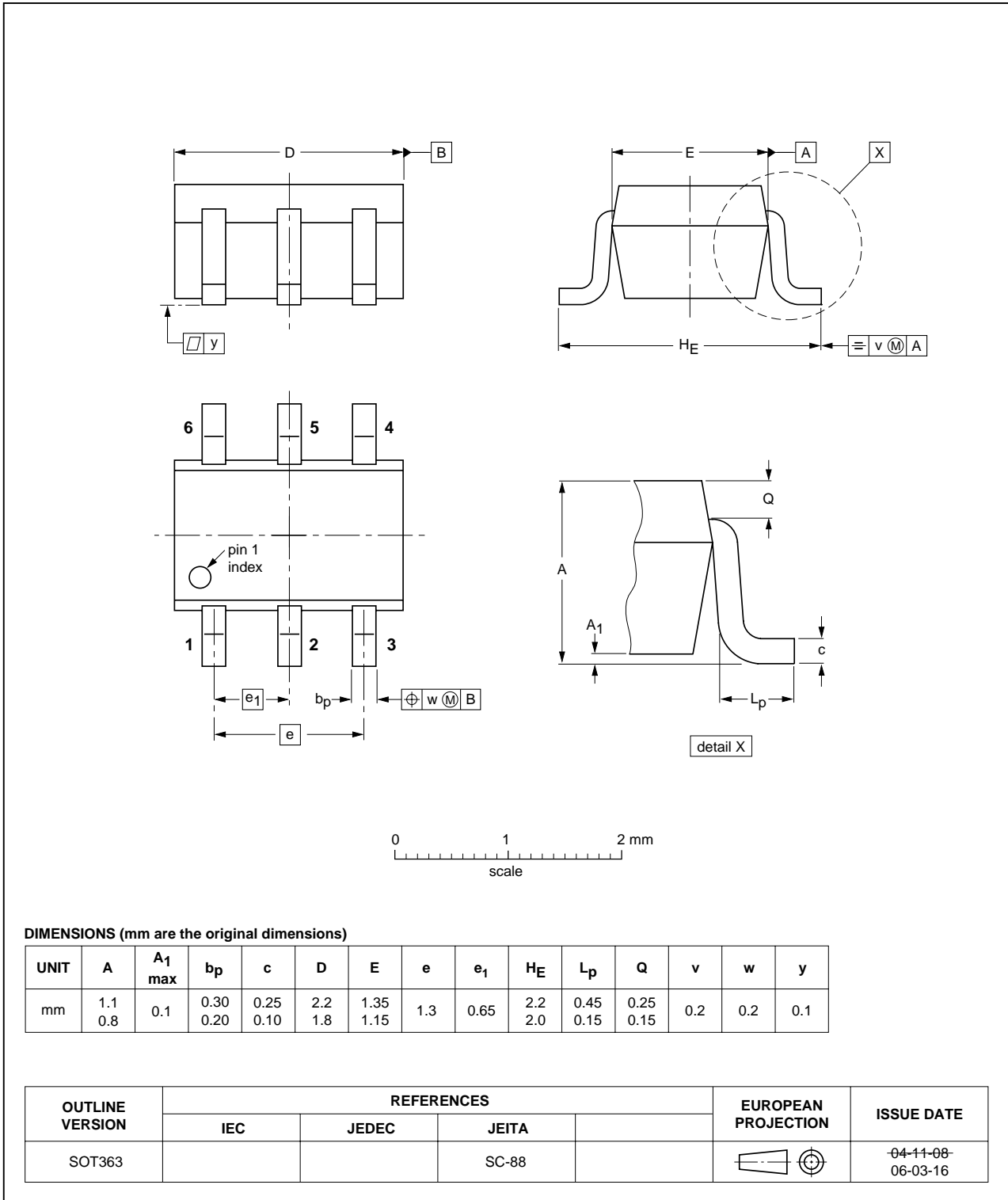


Fig 33. Package outline SOT363

11. Abbreviations

Table 14. Abbreviations

| Acronym | Description |
|---------|---|
| AGC | Automatic Gain Control |
| DC | Direct Current |
| MOSFET | Metal-Oxide-Semiconductor Field-Effect Transistor |
| UHF | Ultra High Frequency |
| VHF | Very High Frequency |

12. Revision history

Table 15. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|-------------|--------------|--------------------|---------------|------------|
| BF1210_1 | 20061025 | Product data sheet | - | - |

13. Legal information

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| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
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| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Date of release: 25 October 2006

Document identifier: BF1210_1



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